Notice of References Cited

	Application/Control No. 10/645,442		Applicant(s)/Patent Ur Reexamination CHEN, LI CHIN OU	ider .
	Examiner	Art Unit		
	Kien T. Nguyen	3714 Pa	ge 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2,317,939	04-1943	RIDDELL JOHN T	473/604
	В	US-3,506,265	04-1970	YUGI HIROSHI	473/604
	С	US-4,187,134	02-1980	Svub et al.	156/170
	D	US-5,096,756	03-1992	Walters, Peter J.	428/35.5
	Е	US-5,681,233	10-1997	Guenther et al.	473/605
	F	US-6,106,419	08-2000	Hall et al.	473/604
Г	G	US-6,390,941	05-2002	Ou, Tsung Ming	473/605
Г	н	US-6,475,119	11-2002	Chow, Andrew E.	482/49
	1.	US-6,503,162	01-2003	Shishido et al.	473/605
	Ĵ	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				,	
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NON-PATENT DOCUMENTS

*	1	Include as a	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	v			0			
	w		*				
	х						

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.